

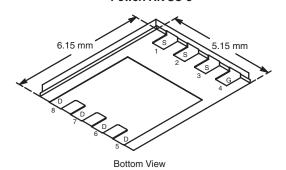


Vishay Siliconix

# N-Channel 40-V (D-S) MOSFET

PRODUCT SUMMARY						
V <sub>DS</sub> (V)	$R_{DS(on)}\left(\Omega\right)$	I <sub>D</sub> (A) <sup>a, e</sup>	Q <sub>g</sub> (Typ.)			
40	0.019 at V <sub>GS</sub> = 10 V	21	5.8 nC			
	0.0225 at V <sub>GS</sub> = 4.5 V	19.6	5.6 110			

#### PowerPAK SO-8



Ordering Information: SiR836DP-T1-GE3 (Lead (Pb)-free and Halogen-free)

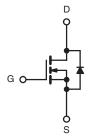
#### **FEATURES**

- Halogen-free According to IEC 61249-2-21 Definition
- TrenchFET<sup>®</sup> Power MOSFET
- 100 % R<sub>q</sub> and UIS Tested
- Compliant to RoHS Directive 2002/95/EC

## ROHS COMPLIANT HALOGEN FREE

#### **APPLICATIONS**

- POL
- Synchronous Rectification



N-Channel MOSFET

ABSOLUTE MAXIMUM RATIN	Symbol	Limit	Unit		
Parameter				Unit	
Drain-Source Voltage		$V_{DS}$	40	V	
Gate-Source Voltage		V <sub>GS</sub>	± 20		
	T <sub>C</sub> = 25 °C		21		
Continuous Drain Current (T <sub>.1</sub> = 150 °C)	T <sub>C</sub> = 70 °C	I <sub>D</sub>	17		
Continuous Brain Current (1) = 100 O)	T <sub>A</sub> = 25 °C	ט' 🗌	10.6 <sup>b, c</sup>		
	T <sub>A</sub> = 70 °C		8.5 <sup>b, c</sup>	Α	
Pulsed Drain Current		I <sub>DM</sub>	50		
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C	I <sub>S</sub>	14		
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	'S	3.5 <sup>b, c</sup>		
Single Pulse Avalanche Current	L = 0.1 mH	I <sub>AS</sub>	10		
Avalanche Energy	L=0.11IIII	E <sub>AS</sub>	5	mJ	
	T <sub>C</sub> = 25 °C		15.6		
Maximum Power Discinction	T <sub>C</sub> = 70 °C	P <sub>D</sub>	10	w	
Maximum Power Dissipation	T <sub>A</sub> = 25 °C	' D	3.9 <sup>b, c</sup>	VV	
	T <sub>A</sub> = 70 °C	1	2.5 <sup>b, c</sup>		
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C	
Soldering Recommendations (Peak Tempera	ature) <sup>f, g</sup>		260	1	

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient <sup>b, d</sup>	t ≤ 10 s	R <sub>thJA</sub>	27	32	°C/W	
Maximum Junction-to-Case (Drain)	Steady State	R <sub>thJC</sub>	6.4	8.0		

#### Notae:

- a. Based on  $T_C = 25$  °C.
- b. Surface Mounted on 1" x 1" FR4 board.
- c. t = 10 s.
- d. Maximum under Steady State conditions is 70 °C/W.
- e. Package limited.
- f. See Solder Profile (<a href="https://www.vishay.com/ppg?73257">www.vishay.com/ppg?73257</a>). The PowerPAK SO-8 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- g. Rework Conditions: manual soldering with a soldering iron is not recommended for leadless components.

## SiR836DP

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Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}$	40			٧	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	J 050A		50		mV/°C	
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	- I <sub>D</sub> = 250 μA		- 4.8			
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}$ , $I_{D} = 250 \mu\text{A}$	1.2		2.5	V	
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 40 V, V <sub>GS</sub> = 0 V			1	μА	
		V <sub>DS</sub> = 40 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55 °C			10		
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	30			Α	
Drain-Source On-State Resistance <sup>a</sup>	<u> </u>	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 10 A		0.015	0.019		
	R <sub>DS(on)</sub>	$V_{GS} = 4.5 \text{ V}, I_D = 7 \text{ A}$		0.018	0.0225	Ω	
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = 15 V, I <sub>D</sub> = 10 A		35		S	
Dynamic <sup>b</sup>							
Input Capacitance	C <sub>iss</sub>			600		pF	
Output Capacitance	C <sub>oss</sub>	V <sub>DS</sub> = 20 V, V <sub>GS</sub> = 0 V, f = 1 MHz		100			
Reverse Transfer Capacitance	C <sub>rss</sub>	1		50			
Total Gate Charge	Q <sub>g</sub>	$V_{DS} = 20 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 10 \text{ A}$		11.8	18	nC	
				5.8	9		
Gate-Source Charge	$Q_gs$	$V_{DS} = 20 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 10 \text{ A}$		1.6			
Gate-Drain Charge	$Q_gd$			2.1			
Gate Resistance	$R_g$	f = 1 MHz	0.5	2.4	4.8	Ω	
Turn-On Delay Time	t <sub>d(on)</sub>			14	28	ns	
Rise Time	t <sub>r</sub>	$V_{DD}$ = 20 V, $R_L$ = 2 $\Omega$		19	38		
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 10 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$		17	34		
Fall Time	t <sub>f</sub>	]		11	22		
Turn-On Delay Time	t <sub>d(on)</sub>			8	16		
Rise Time	t <sub>r</sub>	$V_{DD} = 20 \text{ V}, R_L = 2 \Omega$		13	26		
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 10 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$		15	30		
Fall Time	t <sub>f</sub>	]		9	18		
Drain-Source Body Diode Characteristi	cs						
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C			14	Α	
Pulse Diode Forward Current <sup>a</sup>	I <sub>SM</sub>				50		
Body Diode Voltage	$V_{SD}$	I <sub>S</sub> = 3 A		0.77	1.1	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>			15	30	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	I <sub>F</sub> = 5 A, dl/dt = 100 A/μs, T <sub>J</sub> = 25 °C		7.5	15	nC	
Reverse Recovery Fall Time	t <sub>a</sub>			8			
Reverse Recovery Rise Time	t <sub>b</sub>	1		7		ns	

## Notes:

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

a. Pulse test; pulse width  $\leq 300~\mu s,$  duty cycle  $\leq 2~\%.$ 

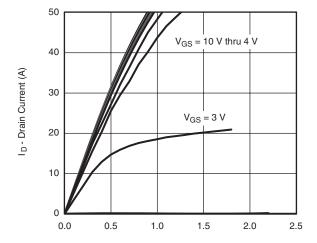
b. Guaranteed by design, not subject to production testing.





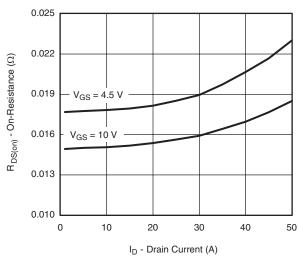
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## TYPICAL CHARACTERISTICS 25 $^{\circ}$ C, unless otherwise noted

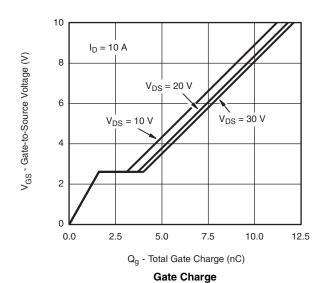


 $V_{\text{DS}}$  - Drain-to-Source Voltage (V)

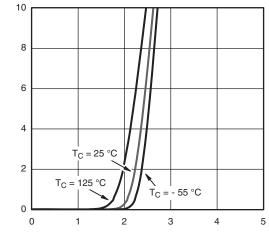




On-Resistance vs. Drain Current and Gate Voltage

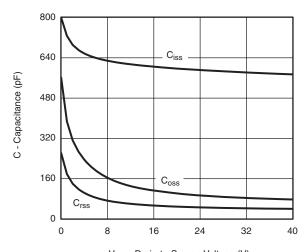


I<sub>D</sub> - Drain Current (A)



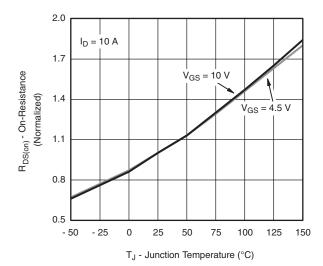
V<sub>GS</sub> - Gate-to-Source Voltage (V)

**Transfer Characteristics** 



 $V_{\mbox{\footnotesize{DS}}}$  - Drain-to-Source Voltage (V)

#### Capacitance



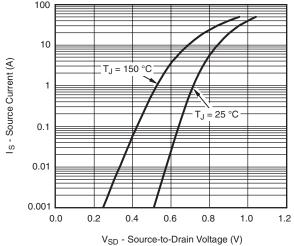
On-Resistance vs. Junction Temperature

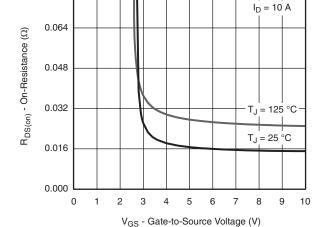
0.080

## SiR836DP

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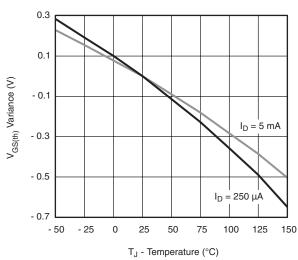
## TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

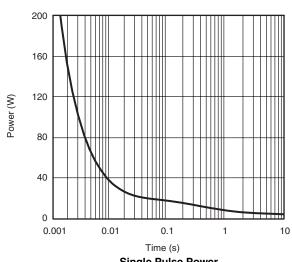




## Source-Drain Diode Forward Voltage

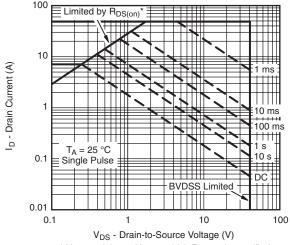






#### **Threshold Voltage**

Single Pulse Power



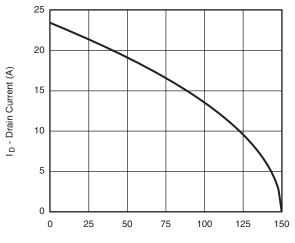
\*  $V_{GS}$  > minimum  $V_{GS}$  at which  $R_{DS(on)}$  is specified

Safe Operating Area, Junction-to-Ambient



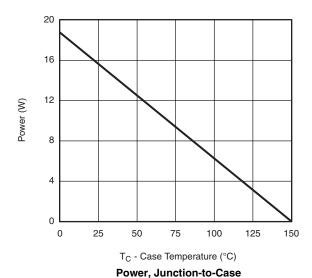
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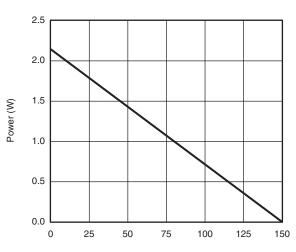
## TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



 $T_{\mbox{\scriptsize C}}$  - Case Temperature (°C)

## Current Derating\*





T<sub>A</sub> - Ambient Temperature (°C)

Power, Junction-to-Ambient

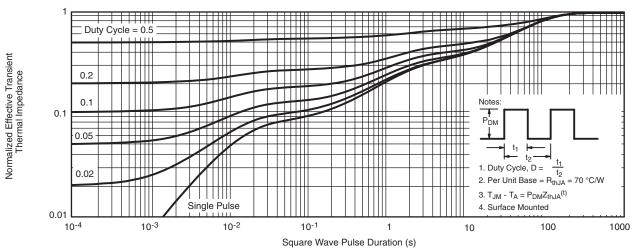
<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J(max)} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

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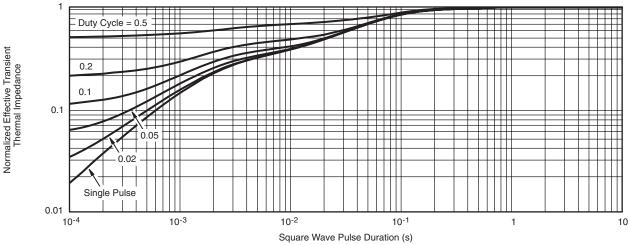
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## TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

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